

Notice of References Cited	Application/Control No. 10/810,210	Applicant(s)/Patent Under Reexamination ONISHI, HITOSHI	
	Examiner Stephen E. Jones	Art Unit 2817	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,724,275	04-2004	Hasegawa, Takashi	333/1.1
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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